

Silicon Power Transistors

The MJ21195 and MJ21196 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

- Total Harmonic Distortion Characterized
- High DC Current Gain -

 $h_{FE} = 25 \text{ Min } @ I_{C} = 8 \text{ Adc}$

- Excellent Gain Linearity
- High SOA: 3 A, 80 V, 1 Second

MJ21195* NPN MJ21196*

*ON Semiconductor Preferred Device

16 AMPERE
COMPLEMENTARY
SILICON POWER
TRANSISTORS
250 VOLTS
250 WATTS

CASE 1-07 TO-204AA (TO-3)

MAXIMUM RATINGS

Rating	Sym- bol	Value	Unit
Collector–Emitter Voltage	VCEO	250	Vdc
Collector–Base Voltage	V _{CBO}	400	Vdc
Emitter–Base Voltage	VEBO	5	Vdc
Collector–Emitter Voltage – 1.5 V	VCEX	400	Vdc
Collector Current — Continuous Peak (1)	IC	16 30	Adc
Base Current — Continuous	ΙΒ	5	Adc
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	PD	250 1.43	Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +200	°C

THERMAL CHARACTERISTICS

Characteristic		Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.7	°C/W

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C \pm 5^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS					
Collector–Emitter Sustaining Voltage (I _C = 100 mAdc, I _B = 0)	VCEO(sus)	250	_	_	Vdc
Collector Cutoff Current (V _{CE} = 200 Vdc, I _B = 0)	ICEO	_	_	100	μAdc

(1) Pulse Test: Pulse Width = 5 μ s, Duty Cycle \leq 10%.

(continued)

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS						
Emitter Cutoff Current (V _{CE} = 5 Vdc, I _C = 0)		I _{EBO}	_	_	100	μAdc
Collector Cutoff Current (V _{CE} = 250 Vdc, V _{BE(off)} = 1.5 Vdc)		ICEX	_	_	100	μAdc
SECOND BREAKDOWN						
Second Breakdown Collector Current with Base Forw Biased (VCE = 50 Vdc, t = 1 s (non-repetitive) (VCE = 80 Vdc, t = 1 s (non-repetitive)	I _{S/b}	5 2.5	=	=	Adc	
ON CHARACTERISTICS						
DC Current Gain (IC = 8 Adc, VCE = 5 Vdc) (IC = 16 Adc, VCE = 5 Vdc)		hFE	25 8	_	75	
Base–Emitter On Voltage (IC = 8 Adc, VCE = 5 Vdc)		V _{BE(on)}	_	_	2.2	Vdc
Collector–Emitter Saturation Voltage (I _C = 8 Adc, I _B = 0.8 Adc) (I _C = 16 Adc, I _B = 3.2 Adc)		V _{CE(sat)}	_	_	1.4 4	Vdc
DYNAMIC CHARACTERISTICS						
Total Harmonic Distortion at the Output VRMS = 28.3 V, f = 1 kHz, PLOAD = 100 WRMS	hFE unmatch	T _{HD}	_	0.8	_	%
ed (Matched pair hFE = 50 @ 5 A/5 V)	hFE matched		_	0.08	_	
Current Gain Bandwidth Product (I _C = 1 Adc, V _{CE} = 10 Vdc, f _{test} = 1 MHz)		fΤ	4	_	_	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1 MHz)		C _{ob}	_	_	500	pF

⁽¹⁾ Pulse Test: Pulse Width = 300 μs, Duty Cycle ≤2%

6.5 f_{T} , CURRENT BANDWIDTH PRODUCT (MHz) 6.0 V_{CE} = 10 V 5.5 5.0 5 V 4.5 4.0 3.5 3.0 2.5 2.0 1.5 T_J = 25°C 1.0 f_{test} = 1 MHz 0.5 0 0.1 1.0 10 IC, COLLECTOR CURRENT (AMPS)

PNP MJ21195

Figure 1. Typical Current Gain Bandwidth Product

NPN MJ21196

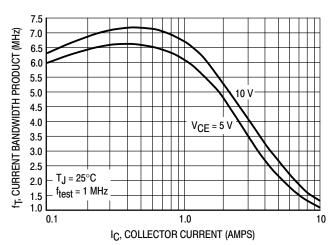


Figure 2. Typical Current Gain Bandwidth Product

TYPICAL CHARACTERISTICS

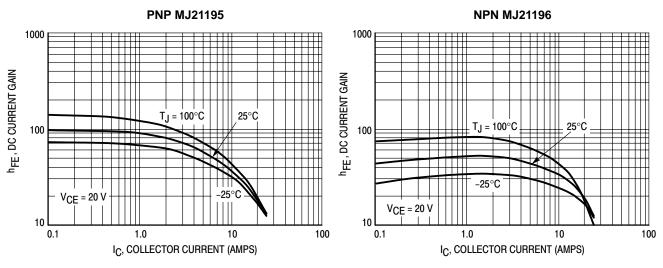


Figure 3. DC Current Gain, V_{CE} = 20 V

Figure 4. DC Current Gain, VCE = 20 V

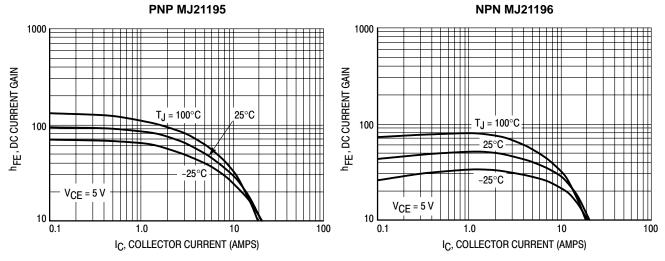


Figure 5. DC Current Gain, VCE = 5 V

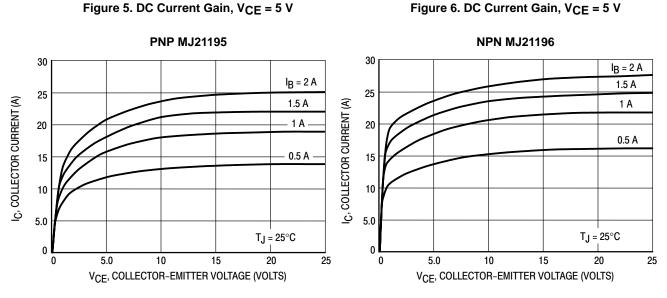


Figure 7. Typical Output Characteristics

Figure 8. Typical Output Characteristics

TYPICAL CHARACTERISTICS

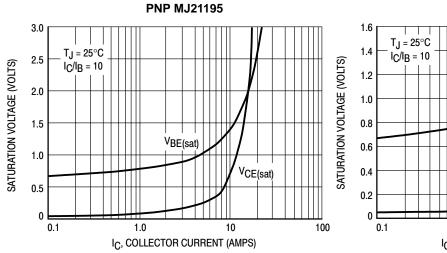


Figure 9. Typical Saturation Voltages

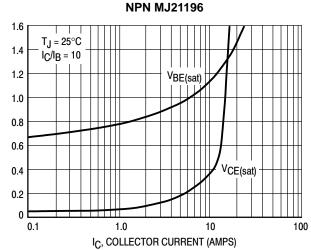


Figure 10. Typical Saturation Voltages

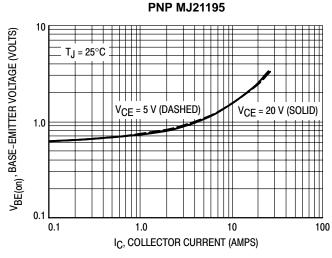


Figure 11. Typical Base-Emitter Voltage

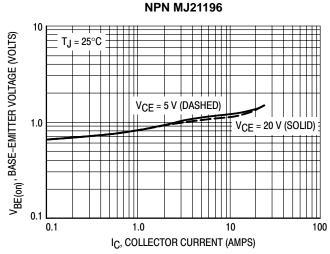


Figure 12. Typical Base-Emitter Voltage

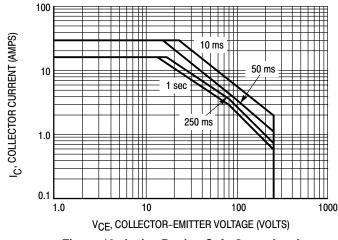


Figure 13. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on $T_{J(pk)} = 200^{\circ}C$; T_{C} is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

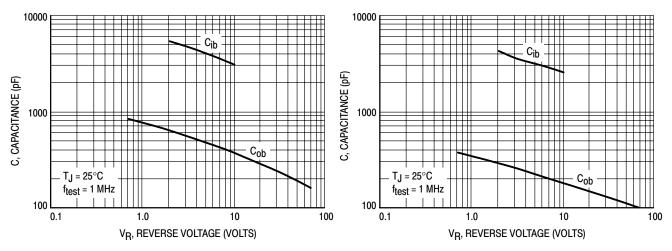


Figure 14. MJ21195 Typical Capacitance

Figure 15. MJ21196 Typical Capacitance

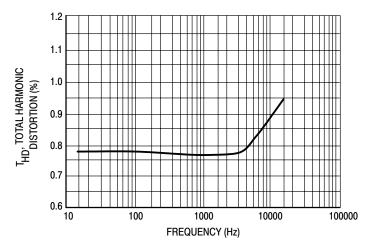


Figure 16. Typical Total Harmonic Distortion

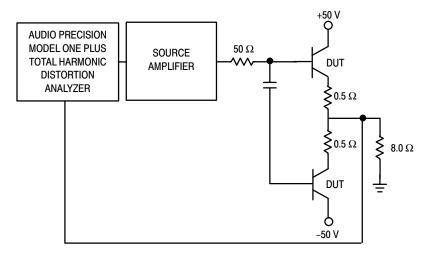
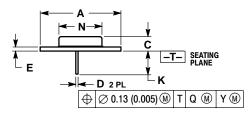
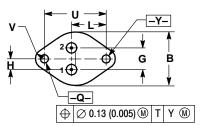


Figure 17. Total Harmonic Distortion Test Circuit

PACKAGE DIMENSIONS

TO-204 (TO-3) CASE 1-07 **ISSUE Z**





- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: INCH.

 3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	1.550	REF	39.37 REF		
В		1.050		26.67	
С	0.250	0.335	6.35	8.51	
D	0.038	0.043	0.97	1.09	
Е	0.055	0.070	1.40	1.77	
G	0.430 BSC		10.92 BSC		
Н	0.215 BSC		5.46 BSC		
K	0.440	0.480	11.18	12.19	
L	0.665	0.665 BSC		16.89 BSC	
N		0.830		21.08	
Q	0.151	0.165	3.84	4.19	
U	1.187 BSC		30.15	BSC	
٧	0.131	0.188	3.33	4.77	



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